



US00D323631S

United States Patent [19]

Berg

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[54] CABINET FOR DUAL PARTICLE AND CELL ANALYSIS OR SIMILAR ARTICLE

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[73] Assignee: Particle Data, Inc., Elmhurst, Ill.

[**] Term: 14 Years

[21] Appl. No.: 435,357

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[52] U.S. Cl. D10/74; D6/436;
D6/438; D24/216; 364/413.08

[58] Field of Search D6/436, 317, 399, 408,
D6/405, 411, 415, 422, 432, 438, 446, 448;
211/34; D10/74, 81; D24/216, 236

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[57] CLAIM

The ornamental design for a cabinet for dual particle and cell analysis, or similar article, as shown.

DESCRIPTION

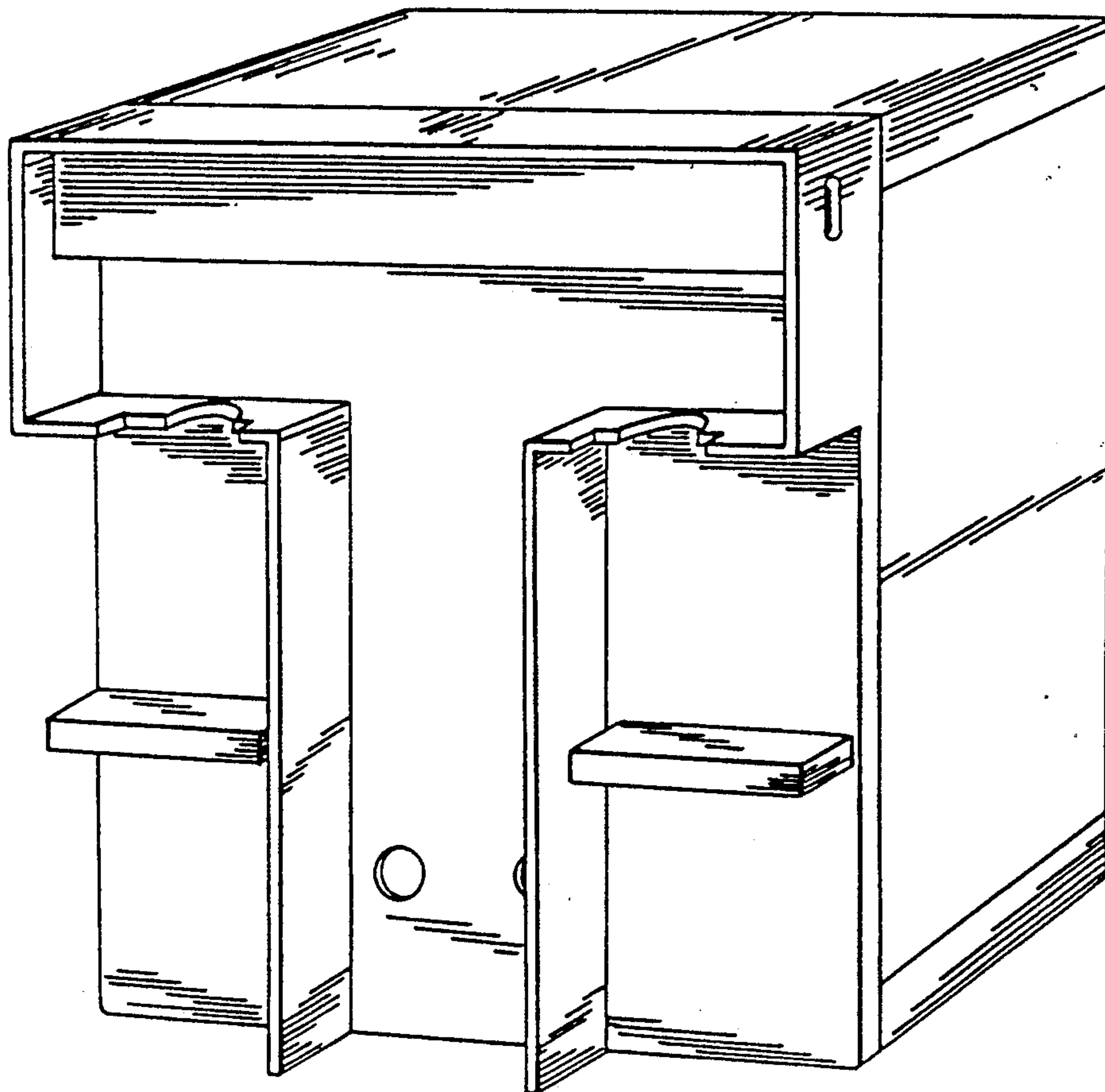
FIG. 1 is a perspective view of a cabinet for dual particle and cell analysis or similar article showing my new design;

FIG. 2 is a right side elevational view thereof;

FIG. 3 is a top plan view thereof;

FIG. 4 is a left side elevational view thereof; and

FIG. 5 is a rear elevational view thereof.



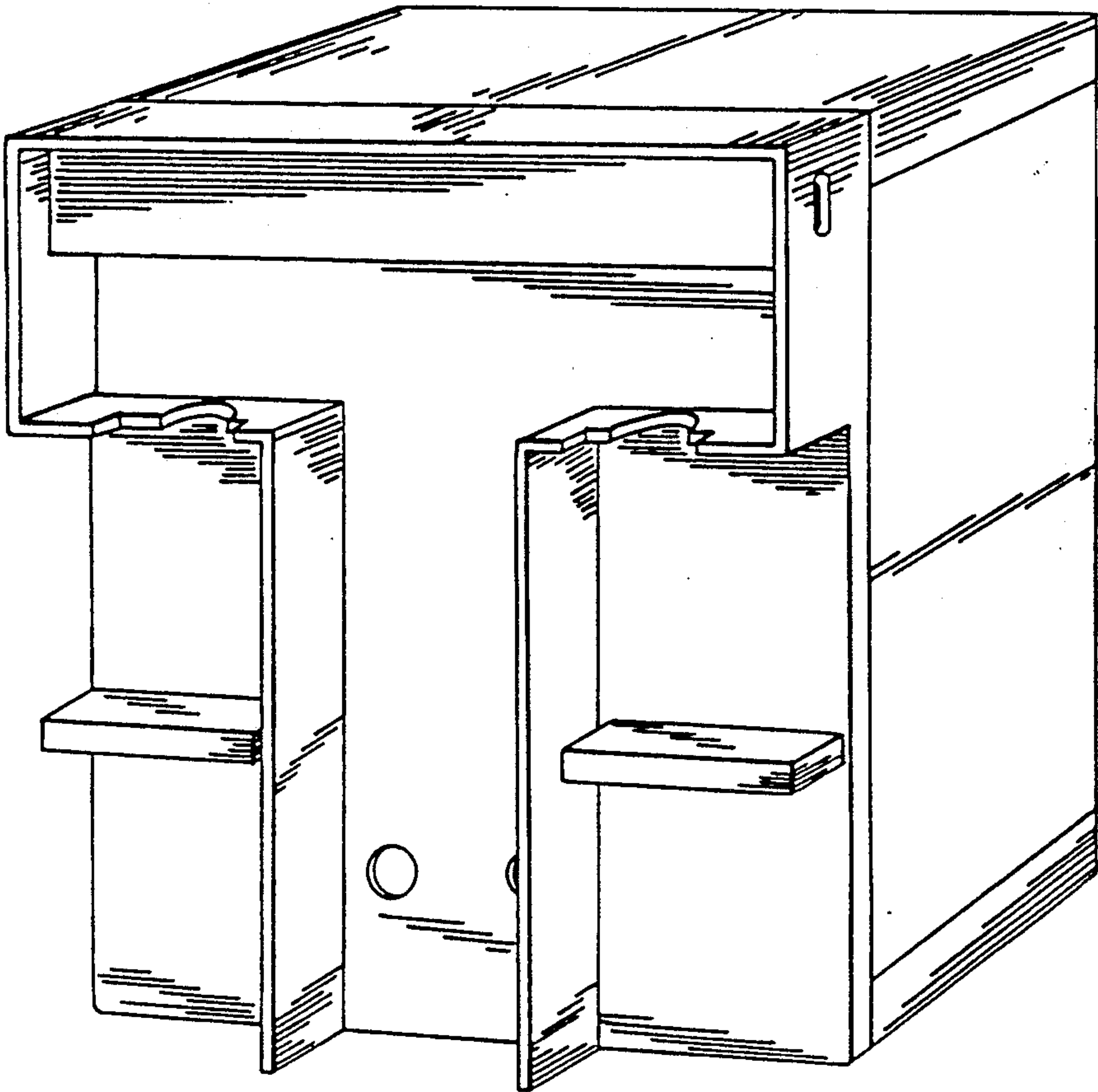


FIG. 1

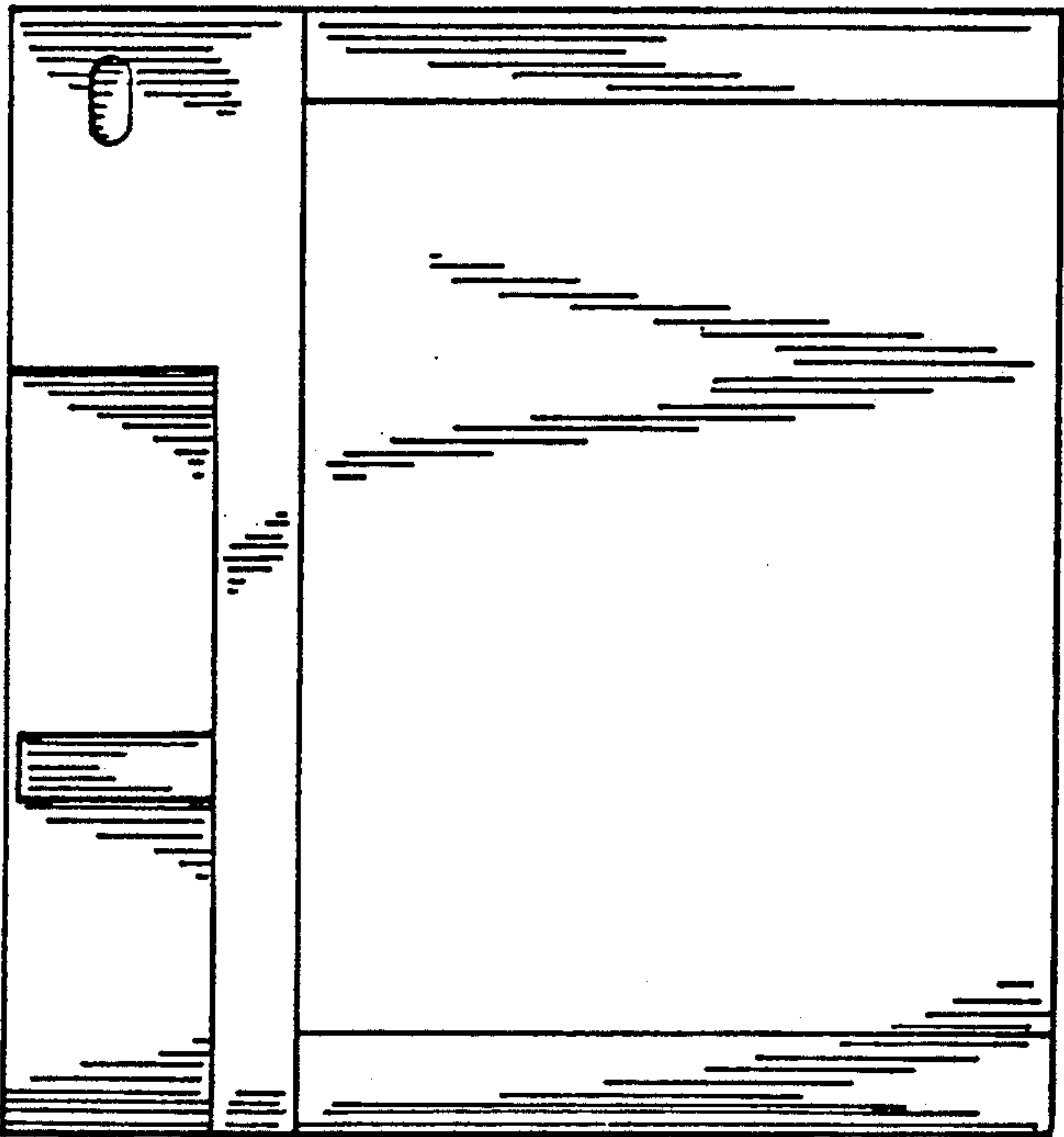


FIG. 2

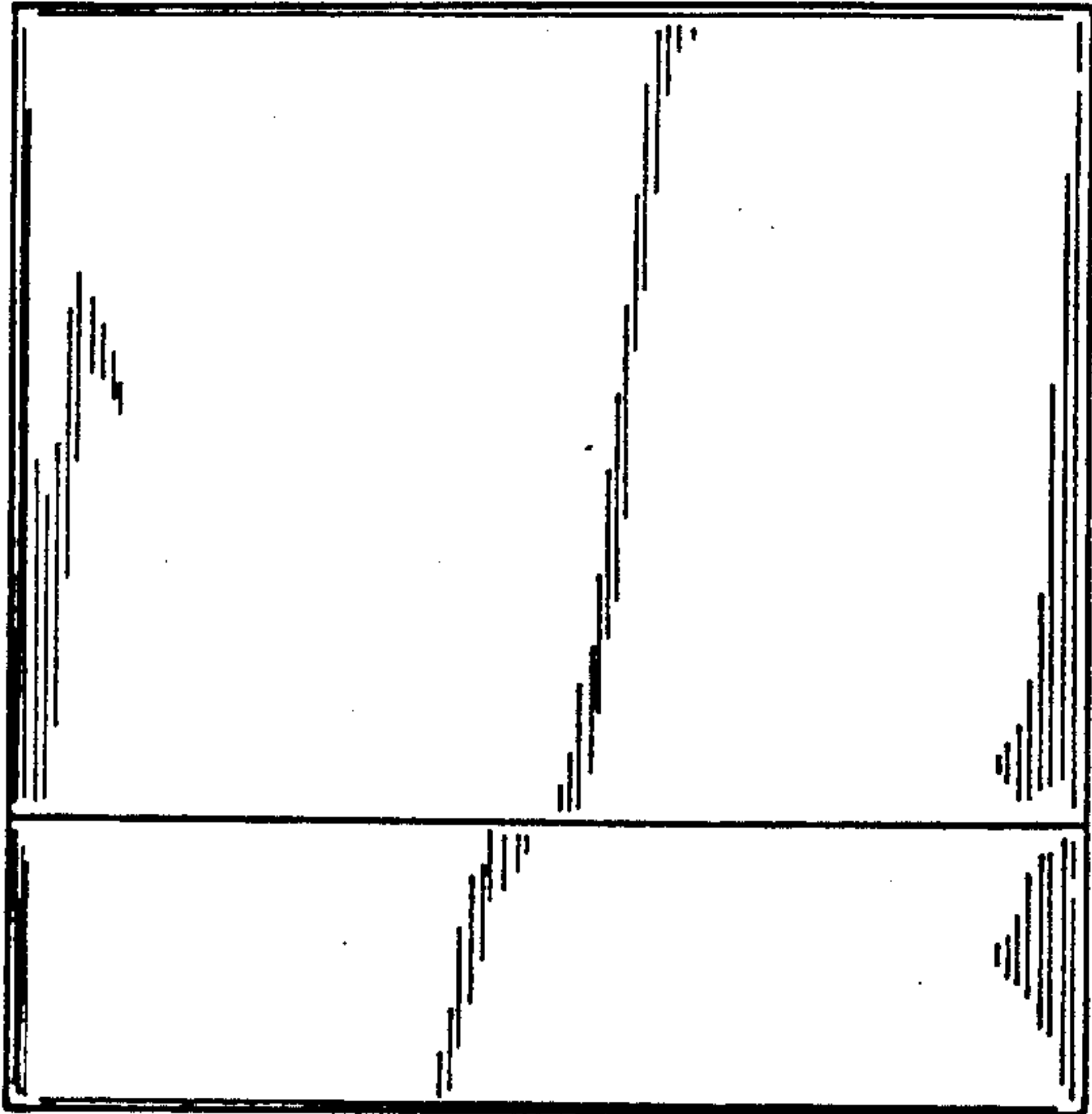


FIG. 3

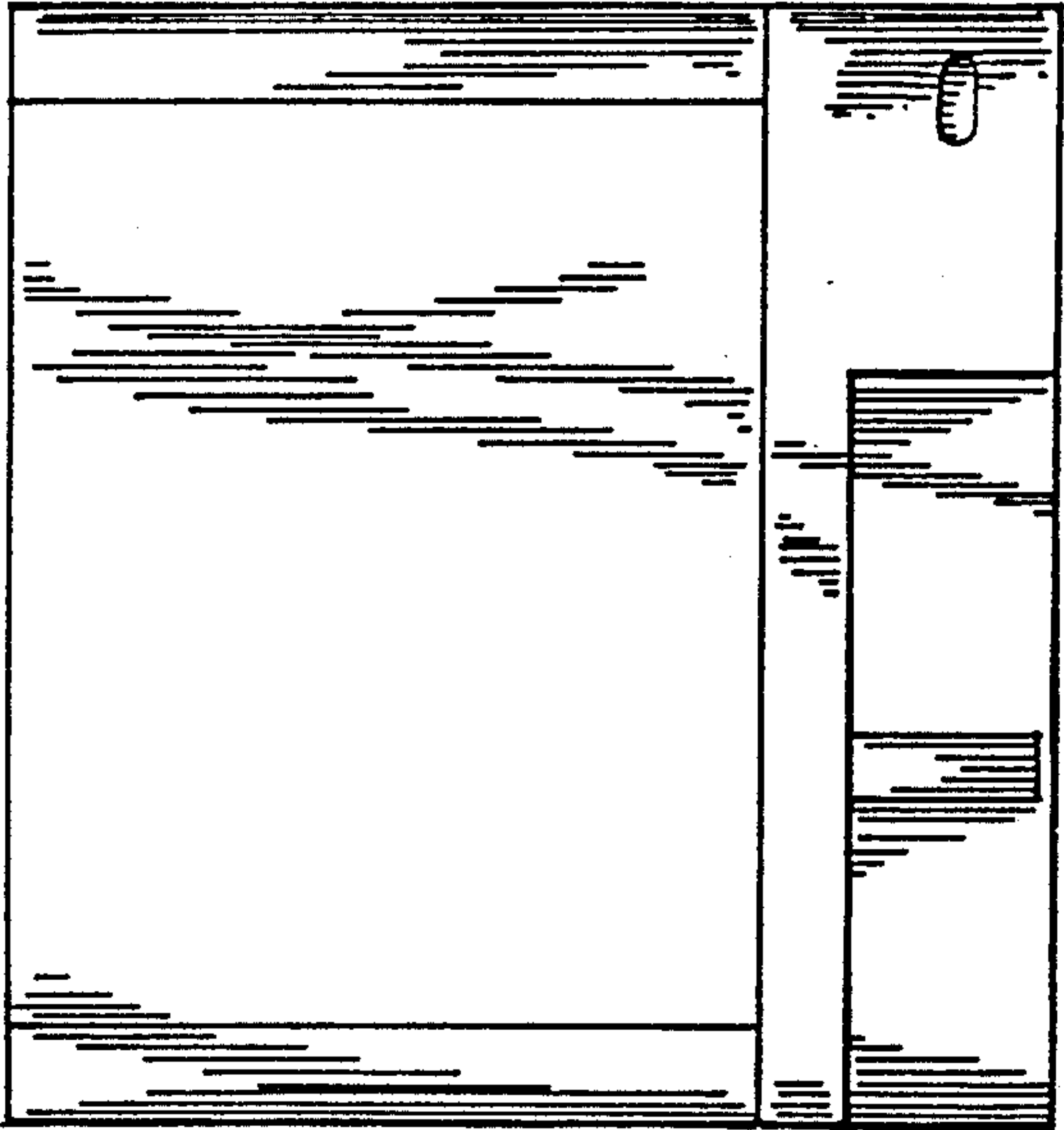


FIG. 4

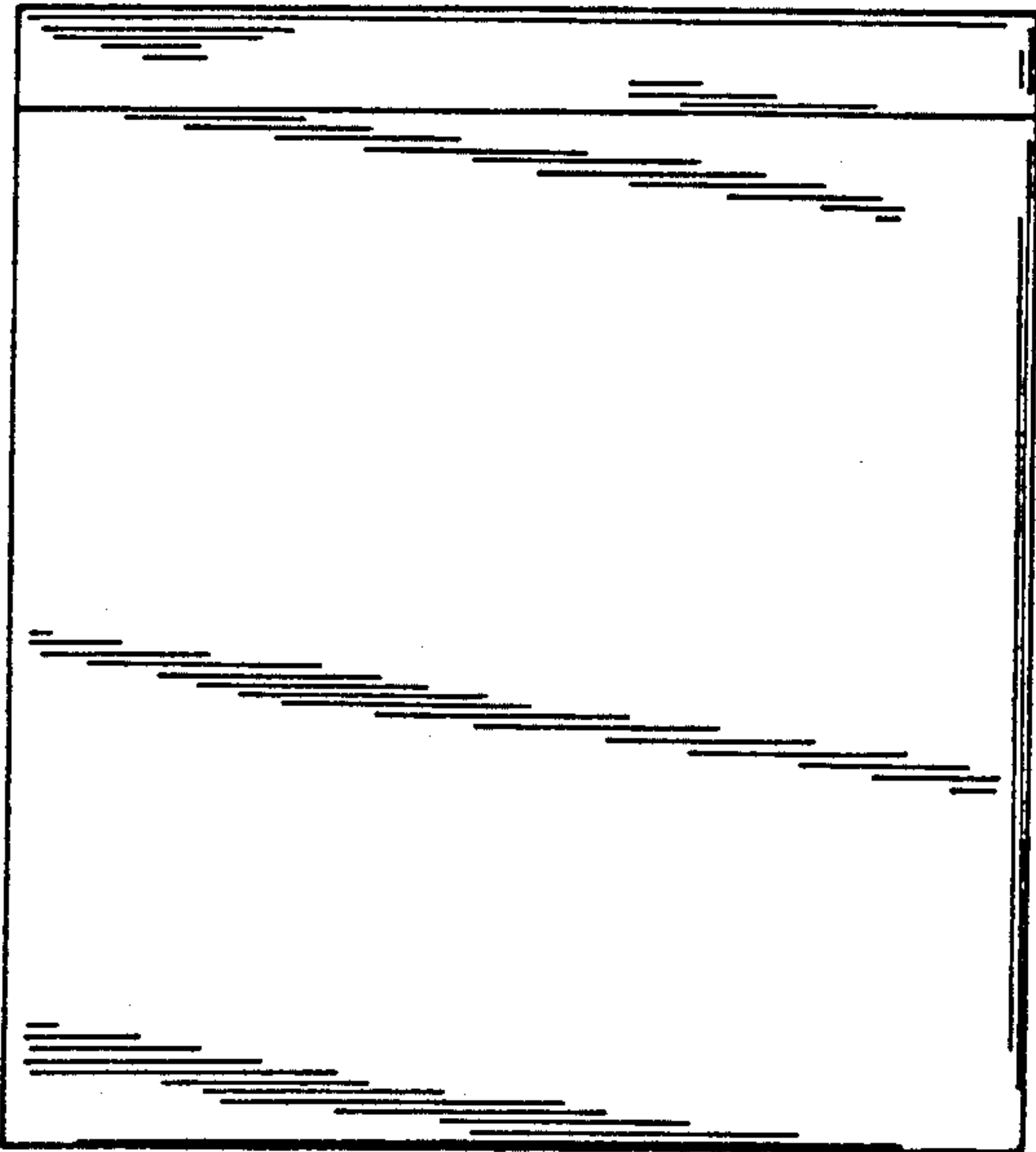


FIG. 5